

**JUL 25 2002**

[illegible]

Examiner Initials	Foreign Patent Document		Country	Date of Publication (MM-DD-YYYY)	Translation	
	Number	Kind Code (if known)			Yes	no
<i>MBn</i>	58-063794	A	Japan (English Translation)	04-15-83		
<i>MBn</i>	53-32274	A	Japan (English Translation)	03-27-78		
<i>MBn</i>	07-118283	A	Japan (English Translation)	05-09-95		
<i>MBn</i>	50-062207	A	Japan (English Translation)	05-28-75		
<i>MBn</i>	47-45487	B1	Japan (English Translation)	11-16-72		
<i>MBn</i>	04-239096	A	Japan (English Translation)	08-26-92		

Examiner Initials	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
MBM	English translation of International Preliminary Examination Report (IPER).
MBM	English translation of Annexes to IPER - Article 34 Amendments (first submission).
MBM	English translation of Annexes to IPER - Article 34 Amendments (second submission).
MBM	

Examiner  
Signature

Margaret B. Medley

Date  
Considered

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SHEET 1 OF 2

Substitute for form 1449A/PTO

ATTORNEY'S DKT NO.  
019970-005APPLICATION NO.  
09/988,401INFORMATION DISCLOSURE  
STATEMENT BY APPLICANTAPPLICANT  
Heijiro OJIMA et alFILING DATE  
November 19, 2001GROUP  
1714

## U.S. PATENT DOCUMENTS

Examiner Initials	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication (MM-DD-YY)
	Number	Kind Code (if known)		
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	4,831,171		Bergfeld et al	05-16-89
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	✓ 3,004,056		Nunn, Jr. et al	10-10-61
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	✓ 3,249,538		Freier	05-03-66
	✓ 3,829,506		Schmolka et al	08-13-74
	✓ 3,833,502		Leary et al	09-13-74
	✓ 3,933,658		Beiswanger et al	01-20-76
	✓ 3,970,569		Sturwold et al	07-20-76
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TC 1700

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Examiner Initials	Foreign Patent Document		Country	Date of Publication (MM-DD-YY)	Translation	
	Number	Kind Code (if known)			Yes	no
MBN ↑	58-063794	A	Japan (w/English Abstract)	04-15-83		
	57-167397	A1	Japan (w/English Abstract)	10-15-82		
	53-32274	A	Japan (w/English Abstract)	03-27-78		
	56-034796	A	Japan (w/English Abstract)	04-07-81		
	✓ 07-118283	A	Japan (w/English Abstract)	05-09-95		
	50-062207	A	Japan (w/English Abstract)	05-28-75		
	✓ 38-8117	B1	Japan	06-05-63		
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	47-45487	B1	Japan (w/English Abstract)	11-16-72		
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	MBN ↓		Europe	11-22-90		

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. SEND TO: Assistant Commissioner for Patents, Washington, D.C. 20231.

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SHEET 2 OF 2

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# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

 ATTORNEY'S DKT NO.  
019970-005

 APPLICATION NO.  
09/988,401

 APPLICANT  
Heijiro OJIMA et al

 FILING DATE  
November 19, 2001

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1714

## NON PATENT LITERATURE DOCUMENTS

 Examiner  
Initials

Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

MBM

 J. A. SCHEY, *Tribology in Metalworking, Friction, Lubrication and Wear*, 4.7.8 Phosphate Coatings, Pages 175-178 (1983)

 Examiner  
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